# Noise Models in Qiskit

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Our reduced-noise-model in Qiskit:

https://github.com/BurgerAndreas/qiskit-reduced-noise-model

Qiskit's NoiseModel implementation:

https://qiskit.org/documentation/\_modules/qiskit/providers/aer/noise/device/models.html

## 1 Qiskit's NoiseModel

Qiskit builds noise models based on device properties measured during calibration.

The noise models contain three error sources

- 1. thermal relaxation (relaxation and dephasing)
- 2. depolarizing (Pauli) error
- 3. readout (measurement) error

At every gate, first the thermal relaxation and then the depolarizing error is applied. The strength of the depolarizing error is calculated backwards, to reach a target 'gate error' when combined with the thermal relaxation.

Source:

https://qiskit.org/documentation/\_modules/qiskit/providers/aer/noise/device/models.html

Gate Error The 'gate error' in Qiskit is just the average infidelity. The average infidelity of a noisy quantum channel  $\epsilon$  with a target unitary U is defined as

$$E(\epsilon, U) = 1 - F_{avg}(\epsilon, U) \tag{1}$$

$$F_{avg} = \int d\phi \langle \phi | U^{\dagger} \epsilon(|\phi\rangle \langle \phi |) U | \phi \rangle.$$
 (2)

Gate error: https://qiskit.org/documentation/stubs/qiskit.quantum\_info.gate\_error.html Fidelity: https://qiskit.org/documentation/stubs/qiskit.quantum\_info.average\_gate\_fidelity.html#qiskit.quantum\_info.average\_gate\_fidelity

#### 1.1 Error sources

**Thermal relaxation** Thermal relaxation is parameterized by T1, T2, and the gate-dependent gate time.

T1 is qubit-specific time until relaxation, i.e. to decay from the excited state to the ground state. T2 qubit-specific coherence time, or time until dephasing. The qubit frequency is the difference in energy between the ground and excited states

In general  $T_2 \leq 2T_1$ . For  $T_2 < T_1$  thermal relaxation can be described by (assuming device to be at 0 temperature) [GEZ21]

$$K_{T_0} = \sqrt{p_I} \mathbb{1}, \ K_{T_1} = \sqrt{p_Z} \hat{\sigma}^z, \ K_{T_2} = \sqrt{p_{reset}} |0\rangle \langle 0|$$
 (3)

$$E_T(\rho) = \sum_{i=10}^{2} K_{T_i} \rho K_{T_i}^{\dagger} \tag{4}$$

It is composed of the probabilities of a phase-flip  $p_Z = (1 - p_{reset})(1 - \frac{p_{T_2}}{p_{T_1}})/2$ , a reset to the ground state  $p_{reset} = 1 - p_{T_1}$ , or for nothing to happen  $p_I = 1 - p_Z - p_{reset}$ .

If  $2T_1 \ge T_2 > T_1$  thermal relaxation is described by the Choi matrix  $\rho \to E_T(\rho) = tr_1[C(\rho^T \otimes I)]$ 

$$\begin{pmatrix}
1 & 0 & 0 & p_{T_2} \\
C = \begin{pmatrix}
0 & 0 & 0 & 0 \\
0 & 0 & p_{reset} & 0 \\
p_{T_2} & 0 & 0 & 1 - p_{reset}
\end{pmatrix}$$
(5)

**Depolarizing** The depolarizing noise (or Pauli) channel is composed of either a bit-flip  $(\hat{\sigma}^x)$ , a phase-flip  $(\hat{\sigma}^z)$  or both at the same time  $(\hat{\sigma}^y)$  with equal probability [GEZ21].

$$\rho \to E_P(\rho) = \sum_{i=1}^3 K_{P_i} \rho K_{P_i}^{\dagger} \tag{6}$$

$$K_{P_0} = \sqrt{1 - p_p} \mathbb{1}, \ K_{P_1} = \sqrt{\frac{p_p}{3}} \hat{\sigma}^x$$
 (7)

$$K_{P_2} = \sqrt{\frac{p_p}{3}} \hat{\sigma}^y, \ K_{P_3} = \sqrt{\frac{p_p}{3}} \hat{\sigma}^z$$
 (8)

In Qiskit the strength of the depolarizing error is calculated from the target gate infidelity  $\mathcal{I}_{gate}$ , and the infidelity due to thermal relaxation  $\mathcal{I}_T$ . If we write the depolarizing error in terms of the identity and the complete depolarizing channel  $E_P = (1 - p_P) * \mathbb{1} + p_P * D$ , we can rewrite the gate fidelity

$$\mathcal{F}_{aate} = 1 - \mathcal{I}_{aate} \tag{9}$$

$$= \mathcal{F}(E_P * E_T) \tag{10}$$

$$= (1 - p_P)\mathcal{F}(1 * E_T) + p_P * \mathcal{F}(D * E_T)$$
(11)

$$= (1 - p_P)\mathcal{F}(E_T) + p_P * \mathcal{F}(D) \tag{12}$$

$$= (1 - p_P)\mathcal{F}_T + p_P * \mathcal{F}_P \tag{13}$$

$$= \mathcal{F}_T - p_P * (d * \mathcal{F}_T - 1)/d \tag{14}$$

Where  $d = 2^{qubits}$  is the dimensionality of the gate. From this the solution for the depolarizing error probability is

$$p_P = d(\mathcal{F}_T - \mathcal{F}_{gate})/(d * \mathcal{F}_T - 1)$$
(15)

$$= d * (\mathcal{I}_{aate} - \mathcal{I}_T) / (d * \mathcal{F}_T - 1) \tag{16}$$

(17)

Source: https://qiskit.org/documentation/\_modules/qiskit/providers/aer/noise/device/models.html

Measurement error The measurement error is equivalent to a bit-flip followed by a noiseless readout [GEZ21]

$$K_{(R_0)} = \sqrt{1 - p_R} \mathbb{1}, \ K_{(R_1)} = \sqrt{p_R} \hat{\sigma}^x$$
 (18)

In Qiskit the readout error is given by the probability P(n|m) of recording a noisy measurement outcome as n, given the true measurement outcome is m.

https://qiskit.org/documentation/stubs/qiskit.providers.aer.noise.ReadoutError.html

#### 1.2 Our Reduced-Noise Model in Qiskit

For our reduced-noise models we multiply the gate error  $\mathcal{I}_{gate}$  and the gate times by a factor  $\xi < 1$ . I.e. we reduce the average gate infidelity  $\mathcal{I}_{gate}$ , while keeping the relative contribution of the thermal relaxation and depolarizing error unchanged. In addition, we scale down the false-readout probabilities P(1|0), P(0|1) by the same factor.

$$\mathcal{I}_{gate} \to \xi * \mathcal{I}_{gate}$$
 (19)

$$\mathcal{I}_t \to \xi * \mathcal{I}_t$$
 (20)

$$P(1|0), P(0|1) \to \xi * P(1|0), \xi * P(0|1)$$
 (21)

For example, as a basis we use the 27 qubit IBMQ Toronto device with a Falcon r4 processor, V1.7.7. At the time of writing the the average calibration data is: Avg. CNOT Error: 4.936e - 2, Avg. Readout Error: 4.119e - 2, Avg. T1: 113.87 us, Avg. T2: 101.63 us, Avg. Gate time: 454.095 ns, Avg. Qubit Frequency: 5.08 GHz, Avg. Qubit Anharmonicity -0.329 GHz.

Our implementation: https://github.com/BurgerAndreas/qiskit-reduced-noise-model

Calibration data: https://quantum-computing.ibm.com/services/resources

### 1.3 Further Reading

 $Custom\ noise\ models\ can\ be\ build\ by\ adding\ Quantum Error\ and\ Readout Error\ objects\ to\ Noise Models$ 

https://qiskit.org/documentation/tutorials/simulators/3\_building\_noise\_models.html

https://qiskit.org/documentation/apidoc/aer\_noise.html

Device error parameters (and it's NoiseModel) can be accessed via it's BackendProperties

https://qiskit.org/documentation/apidoc/aer\_noise.html

Basic information on the devices can be accessed via it's BackendConfiguration

https://qiskit.org/documentation/stubs/qiskit.providers.models.BackendConfiguration.html

Examples can be found in further\_reading.ipynb under

https://github.com/BurgerAndreas/qiskit-reduced-noise-model

#### References

[GEZ21] Konstantinos Georgopoulos, Clive Emary, and Paolo Zuliani. Modeling and simulating the noisy behavior of near-term quantum computers. *Physical Review A*, 104(6):062432, dec 2021.